



# N-channel 620 V, 1.7 $\Omega$ , 4.5 A Power MOSFET in a DPAK package

Datasheet - preliminary data

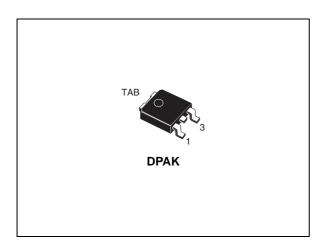
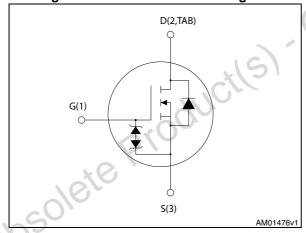


Figure 1. Internal schematic diagram



#### **Features**

Order code	V <sub>DS</sub>	R <sub>DS(on)</sub> max	I <sub>D</sub>	P <sub>TOT</sub>
STDLED625H	620 V	2 Ω	4.5 A	70 W

- 100% avalanche tested
- Extremely high dv/dt capability
- Gate charge minimized
- Very low intrinsic capacitance
- Improved diode reverse recovery characteristics
- Zener-protected

#### **Applications**

• LED lighting applications

### **Description**

These Power MOSFETs boast extremely low onresistance and very good dv/dt capability, rendering them suitable for buck-boost and flyback topologies.

**Table 1. Device summary** 

Order code	Marking	Package	Packaging
STDLED625H	LED625H	DPAK	Tape and reel

Contents STDLED625H

## **Contents**

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STDLED625H Electrical ratings

# 1 Electrical ratings

Table 2. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V <sub>DS</sub>	Drain-source voltage	620	V
V <sub>GS</sub>	Gate- source voltage	± 30	V
I <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 25 °C	4.5	А
I <sub>D</sub>	Drain current (continuous) at T <sub>C</sub> = 100 °C	2.3	А
I <sub>DM</sub> <sup>(1)</sup>	Drain current (pulsed)	18.0	Α
P <sub>TOT</sub>	Total dissipation at T <sub>C</sub> = 25 °C	70	W
I <sub>AR</sub>	Avalanche current, repetitive or not- repetitive (pulse width limited by T <sub>j</sub> max)	3.8	А
E <sub>AS</sub>	Single pulse avalanche energy (starting $T_j = 25$ °C, $I_D = I_{AR}$ , $V_{DD} = 50$ V)	115	mJ
V <sub>ESD(G-S)</sub>	Gate source ESD(HBM-C = 100 pF, R = 1.5 k $\Omega$ )	2500	V
dv/dt (2)	Peak diode recovery voltage slope	12	V/ns
V <sub>ISO</sub>	Insulation withstand voltage (RMS) from all three leads to external heat sink (t = 1 s; Tc = 25 °C)		V
T <sub>stg</sub>	Storage temperature	- 55 to 150	°C
Tj	Max. operating junction temperature	150	°C

<sup>1.</sup> Pulse width limited by safe operating area.

Table 3. Thermal data

Symbol	Parameter	Value	Unit
R <sub>thj-case</sub>	Thermal resistance junction-case max	1.79	°C/W
R <sub>thj-pcb</sub> (1)	Thermal resistance junction-pcb max	50	°C/W

<sup>1.</sup> When mounted on 1inch<sup>2</sup> FR-4 board, 2 oz Cu.

<sup>2.</sup>  $I_{SD} \leq 3.8 \text{ A, di/dt} = 400 \text{ A/}\mu\text{s, V}_{DD} = 80\% \text{ V}_{(BR)DSS}, \text{V}_{DS} \text{ peak} \leq \text{V}_{(BR)DSS}.$ 

**Electrical characteristics** STDLED625H

#### 2 **Electrical characteristics**

(T<sub>C</sub> = 25 °C unless otherwise specified)

Table 4. On /off states

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)DSS</sub>	Drain-source breakdown voltage	V <sub>GS</sub> = 0, I <sub>D</sub> = 1 mA	620			V
	Zero gate voltage	$V_{GS} = 0, V_{DS} = 620V$			1	μΑ
I <sub>DSS</sub>	drain current	$V_{GS} = 0$ $V_{DS} = 620V, T_{C} = 125 °C$			50	μΑ
I <sub>GSS</sub>	Gate-body leakage current	$V_{DS} = 0, V_{GS} = \pm 20 \text{ V}$		YUC	± 10	μΑ
V <sub>GS(th)</sub>	Gate threshold voltage	$V_{DS} = V_{GS}$ , $I_D = 50 \mu A$	3	3.6	4.5	V
R <sub>DS(on</sub>	Static drain-source on- resistance	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 1.9 A		1.7	2	Ω

Table 5. Dynamic

	Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
	C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input capacitance Output capacitance Reverse transfer capacitance	$V_{DS} = 50 \text{ V, f} = 1 \text{ MHz,}$ $V_{GS} = 0$	-	560 43 7.5	-	pF pF pF
	C <sub>oss eq.</sub> <sup>(1)</sup>	Equivalent output capacitance	V <sub>DS</sub> = 0 to 496 V, V <sub>GS</sub> = 0	ı	27	ı	pF
0	$R_{G}$	Intrinsic gate resistance	f = 1 MHz open drain	2	5	10	Ω
1/6	$Q_g$	Total gate charge	$V_{DD} = 496 \text{ V}, I_D = 3.8 \text{ A},$		23		nC
50	$Q_{gs}$	Gate-source charge	V <sub>GS</sub> = 10 V	-	4	-	nC
	$Q_{gd}$	Gate-drain charge	(see Figure 16)		13		nC
	1. C <sub>oss eq.</sub> is	defined as a constant equiv	valent capacitance giving the same cl	harging tir	me as C <sub>os</sub>	s when V	DS

<sup>1.</sup>  $C_{oss\ eq.}$  is defined as a constant equivalent capacitance giving the same charging time as  $C_{oss}$  when  $V_{DS}$  increases from 0 to 80%  $V_{DSS}$ 

Table 6. Switching times

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
$t_{d(on)}$ $t_r$ $t_{d(off)}$ $t_f$	Turn-on delay time Rise time Turn-off-delay time Fall time	$V_{DD} = 300 \text{ V}, I_{D} = 1.9 \text{ A},$ $R_{G} = 4.7 \Omega, V_{GS} = 10 \text{ V}$ (see Figure 15)	-	10 9 29 19	-	ns ns ns

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I <sub>SD</sub>	Source-drain current Source-drain current (pulsed)		-		3.8 15.2	A A
V <sub>SD</sub> (2)	Forward on voltage	I <sub>SD</sub> = 3.8 A, V <sub>GS</sub> = 0	-		1.6	V
t <sub>rr</sub> Q <sub>rr</sub> I <sub>RRM</sub>	Reverse recovery time Reverse recovery charge Reverse recovery current	I <sub>SD</sub> = 3.8 A, di/dt = 100 A/μs V <sub>DD</sub> = 60 V (see <i>Figure 20</i> )	1	220 1.4 13		ns µC A
t <sub>rr</sub> Q <sub>rr</sub> I <sub>RRM</sub>	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 3.8 \text{ A, di/dt} = 100 \text{ A/µs}$ $V_{DD} = 60 \text{ V, T}_j = 150 ^{\circ}\text{C}$ (see <i>Figure 20</i> )	-	270 1.9 14	19	ns µC A

Table 7. Source drain diode

- 1. Pulse width limited by safe operating area.
- 2. Pulsed: Pulse duration =  $300 \mu s$ , duty cycle 1.5%

Table 8. Gate-source Zener diode

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)GSO</sub>	Gate-source breakdown voltage	$I_{GS}$ = ± 1 mA, $I_{D}$ =0	30	-	-	V

The built-in back-to-back Zener diodes have been specifically designed to enhance not only the device's ESD capability, but also to make them capable of safely absorbing any voltage transients that may occasionally be applied from gate to source. In this respect, the Zener voltage is appropriate to achieve efficient and cost-effective protection of device integrity. The integrated Zener diodes thus eliminate the need for external components.

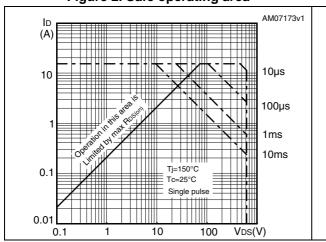
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Electrical characteristics STDLED625H

#### 2.1 Electrical characteristics (curves)

Figure 2. Safe operating area

Figure 3. Thermal impedance



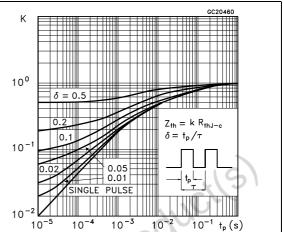
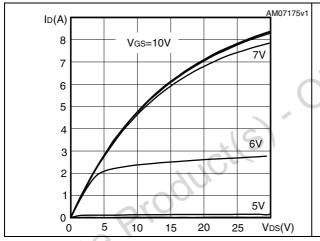


Figure 4. Output characteristics

Figure 5. Transfer characteristics



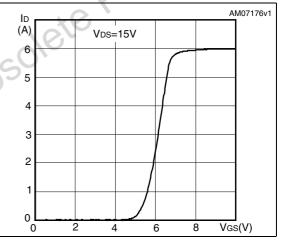
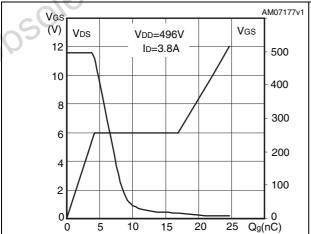
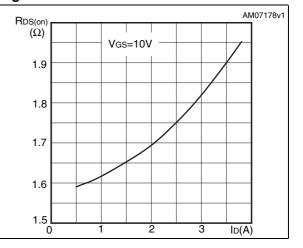


Figure 6. Gate charge vs gate-source voltage

Figure 7. Static drain-source on-resistance





0.1

Figure 8. Capacitance variations

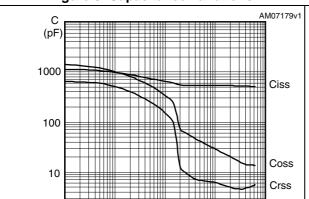


Figure 9. Output capacitance stored energy

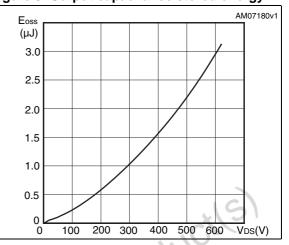


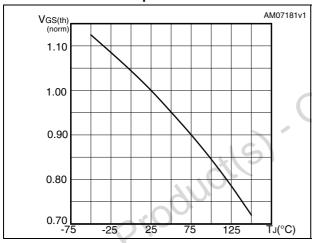
Figure 10. Normalized gate threshold voltage vs temperature

10

100

VDS(V)

Figure 11. Normalized on-resistance vs temperature



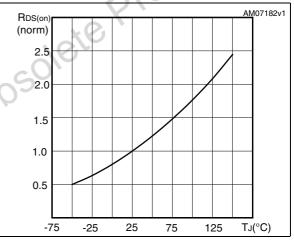
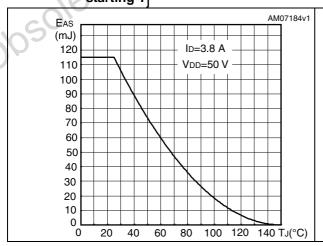
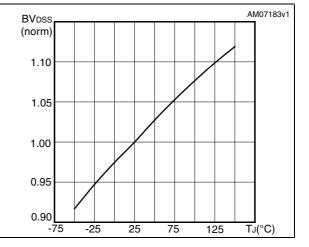


Figure 12. Maximum avalanche energy vs starting T<sub>i</sub>

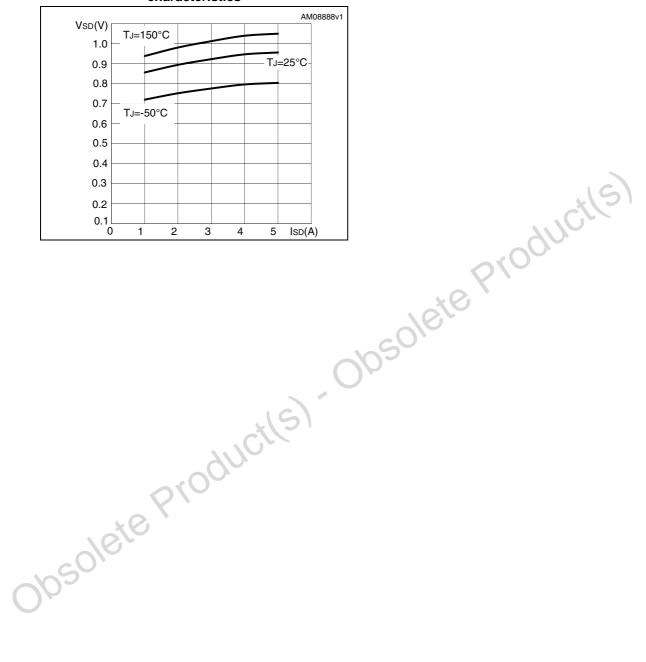
Figure 13. Normalized  $B_{VDSS}$  vs temperature





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Figure 14. Source-drain diode forward characteristics



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STDLED625H Test circuits

## 3 Test circuits

Figure 15. Switching times test circuit for resistive load

Figure 16. Gate charge test circuit

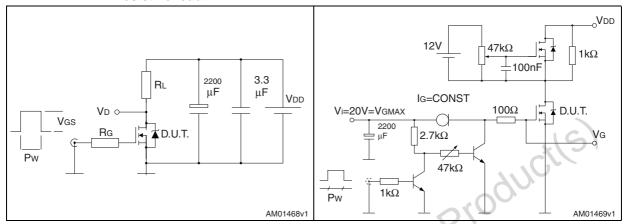


Figure 17. Test circuit for inductive load switching and diode recovery times

Figure 18. Unclamped Inductive load test circuit

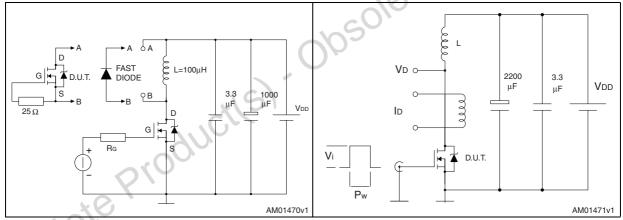
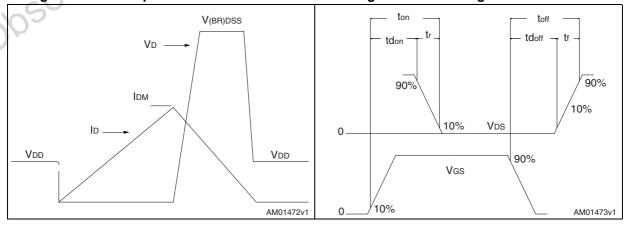


Figure 19. Unclamped inductive waveform

Figure 20. Switching time waveform



## 4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK<sup>®</sup> packages, depending on their level of environmental compliance. ECOPACK<sup>®</sup> specifications, grade definitions and product status are available at: <a href="https://www.st.com">www.st.com</a>. ECOPACK<sup>®</sup> is an ST trademark.

Obsolete Product(s). Obsolete Product(s)

Table 9. DPAK (TO-252) mechanical data

Dim	mm					
Dim.	Min.	Тур.	Max.			
А	2.20		2.40			
A1	0.90		1.10			
A2	0.03		0.23			
b	0.64		0.90			
b4	5.20		5.40			
С	0.45		0.60			
c2	0.48		0.60			
D	6.00		6.20			
D1		5.10	00.0			
E	6.40	0	6.60			
E1		4.70				
е		2.28				
e1	4.40	60,	4.60			
Н	9.35	102	10.10			
L	1.00	,	1.50			
(L1)	16	2.80				
L2	4/3	0.80				
L4	0.60		1.00			
R	0	0.20				
V2	0°		8°			

E -THERMAL PAD c2 *L2* Н R С Josole ie SEATING PLANE (L1) *V2* GAUGE PLANE 0,25 0068772\_K

Figure 21. DPAK (TO-252) drawing

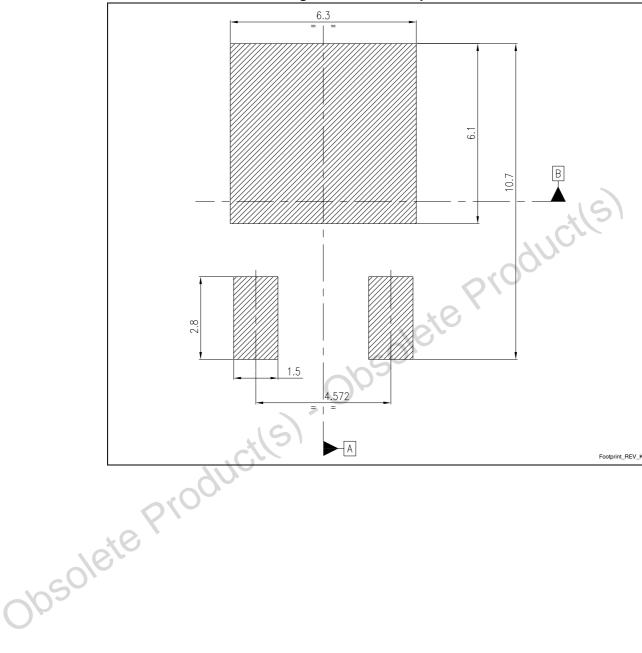


Figure 22. DPAK footprint (a)

a. All dimensions are in millimeters

# 5 Packaging mechanical data

Table 10. DPAK (TO-252) tape and reel mechanical data

Таре			Reel			
	m	m		mm		
Dim.	Min.	Max.	Dim.	Min.	Max.	
A0	6.8	7	Α		330	
В0	10.4	10.6	В	1.5		
B1		12.1	С	12.8	13.2	
D	1.5	1.6	D	20.2	. (C)	
D1	1.5		G	16.4	18.4	
Е	1.65	1.85	N	50		
F	7.4	7.6	Т		22.4	
K0	2.55	2.75	10	10		
P0	3.9	4.1	0//	Base qty.	2500	
P1	7.9	8.1	9	Bulk qty.	2500	
P2	1.9	2.1				
R	40					
Т	0.25	9 0.35				
W	15.7	16.3				
te s	15.7					

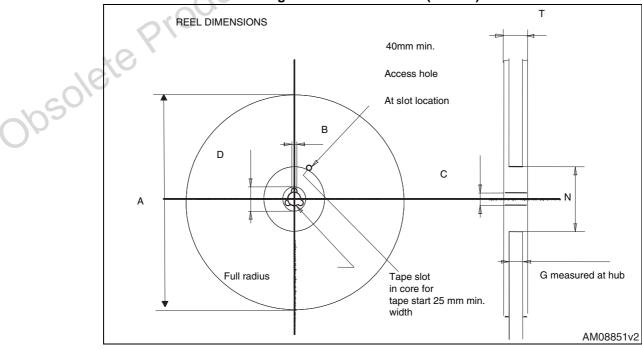
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Top cover tolerance on tape +/- 0.2 mm

Top co

Figure 23. Tape for DPAK (TO-252)





Revision history STDLED625H

## 6 Revision history

**Table 11. Document revision history** 

Date	Revision	Changes
22-Mar-2013	1	First release.

Obsolete Product(s). Obsolete Product(s)

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